#### TOSHIBA MOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

#### 256Mbits Network FCRAM1

- -4,194,304-WORDS  $\times$  4 BANKS  $\times$  16-BITS
- -8,388,608-WORDS  $\times$  4 BANKS  $\times$  8-BITS

#### **DESCRIPTION**

Network FCRAM<sup>TM</sup> is Double Data Rate Fast Cycle Random Access Memory. TC59LM814/06CFT are Network FCRAM<sup>TM</sup> containing 268,435,456 memory cells. TC59LM814CFT is organized as 4,194,304-words  $\times$  4 banks  $\times$  8 bits, TC59LM806CFT is organized as 8,388,608 words  $\times$  4 banks  $\times$  8 bits. TC59LM814/06CFT feature a fully synchronous operation referenced to clock edge whereby all operations are synchronized at a clock input which enables high performance and simple user interface coexistence. TC59LM814/06CFT can operate fast core cycle using the FCRAM<sup>TM</sup> core architecture compared with regular DDR SDRAM.

TC59LM814/06CFT is suitable for Network, Server and other applications where large memory density and low power consumption are required. The Output Driver for Network FCRAM<sup>TM</sup> is capable of high quality fast data transfer under light loading condition.

## **FEATURES**

|   | PARAMETER                                  | TC59LM814/06 |        |         |        |
|---|--|--------------|--------|---------|--------|
|   | PARAIVIETER                                |              |        | -55     | -60    |
| tcĸ   | Clock Cycle Time (min)                     | CL = 3       | 5.5 ns | 6 ns    | 6.5 ns |
| чСК   | Clock Cycle Time (IIIII)                   | CL = 4       | 5 ns   | 5.5 ns  | 6 ns   |
| t <sub>RC</sub>                             | Random Read/Write Cycle Time (m            | in)          | 25 ns  | 27.5 ns | 30 ns  |
| t <sub>RAC</sub>                            | Random Access Time (max)                   |              | 22 ns  | 24 ns   | 26 ns  |
| I <sub>DD1S</sub>                           | Operating Current (single bank) (ma        | ax)          | 190 mA | 180 mA  | 170 mA |
| I <sub>DD2P</sub>                           | I <sub>DD2P</sub> Power Down Current (max) |              | 2 mA   | 2 mA    | 2 mA   |
| I <sub>DD6</sub> Self-Refresh Current (max) |  |              | 3 mA   | 3 mA    | 3 mA   |

- Fully Synchronous Operation
  - Double Data Rate (DDR)

Data input/output are synchronized with both edges of DQS.

- Differential Clock (CLK and \( \overline{CLK} \)) inputs
  - $\overline{\text{CS}}$ , FN and all address input signals are sampled on the positive edge of CLK. Output data (DQs and DQS) is aligned to the crossings of CLK and  $\overline{\text{CLK}}$ .
- Fast clock cycle time of 5 ns minimum

Clock: 200 MHz maximum

Data: 400 Mbps/pin maximum

- · Quad Independent Banks operation
- · Fast cycle and Short Latency
- Bidirectional Data Strobe Signal
- Distributed Auto-Refresh cycle in 7.8 μs
- Self-Refresh
- Power Down Mode
- Variable Write Length Control
- Write Latency =  $\overline{CAS}$  Latency-1
- Programable CAS Latency and Burst Length

 $\overline{\text{CAS}}$  Latency = 3, 4

Burst Length = 2, 4

• Organization TC59LM814CFT: 4,194,304 words × 4 banks × 16 bits

TC59LM806CFT: 8,388,608 words × 4 banks × 8 bits

• Power Supply Voltage V<sub>DD</sub>:  $2.5 \text{ V} \pm 0.15 \text{ V}$ 

 $V_{DDQ}$ : 2.5 V ± 0.15 V

- 2.5 V CMOS I/O comply with SSTL\_2 (half strength driver)
- Package: 400 × 875 mil, 66 pin TSOPII, 0.65 mm pin pitch (TSOPII66-P-400-0.65)

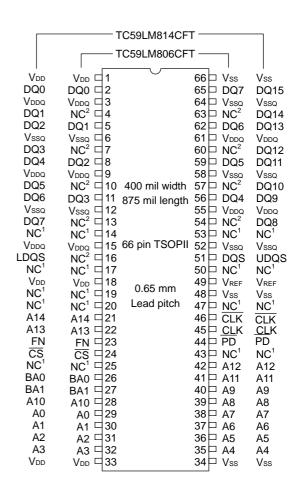
Notice: FCRAM is a trademark of Fujitsu Limited, Japan.

# <u>TOSHIBA</u>

#### **PIN NAMES**

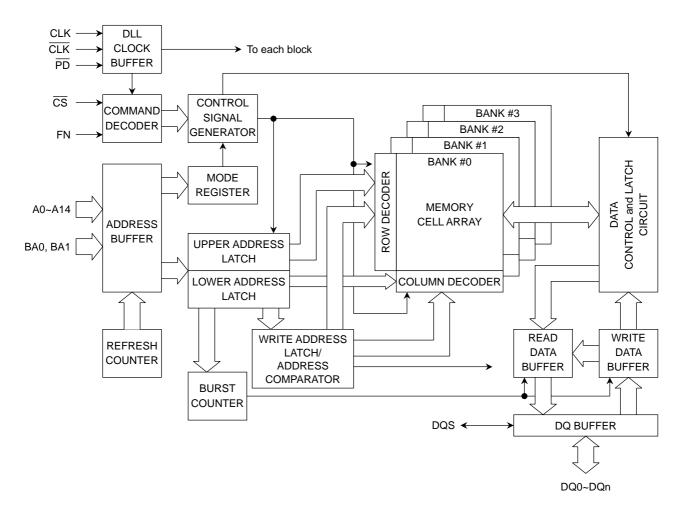
| PIN                               | NAME                               |
|-----------------------------------|------------------------------------|
| A0~A14                            | Address Input                      |
| BA0, BA1                          | Bank Address                       |
| DQ0~DQ7 (×8)                      | Data Input/Quitaut                 |
| DQ0~DQ15 (×16)                    | Data Input/Output                  |
| cs                                | Chip Select                        |
| FN                                | Function Control                   |
| PD                                | Power Down Control                 |
| CLK, CLK                          | Clock Input                        |
| DQS (×8)                          | Write/Read Data Strobe             |
| UDQS/LDQS (×16)                   | Wille/Read Data Strobe             |
| $V_{DD}$                          | Power (+2.5 V)                     |
| V <sub>SS</sub>                   | Ground                             |
| $V_{DDQ}$                         | Power (+2.5 V)<br>(for I/O buffer) |
| V <sub>SSQ</sub>                  | Ground<br>(for I/O buffer)         |
| V <sub>REF</sub>                  | Reference Voltage                  |
| NC <sup>1</sup> , NC <sup>2</sup> | Not Connected                      |

# **PIN ASSIGNMENT (TOP VIEW)**





#### **BLOCK DIAGRAM**



Note: The TC59LM806CFT configuration is 4Bank of  $32768 \times 256 \times 8$  of cell array with the DQ pins numbered DQ0~DQ7. The TC59LM814CFT configuration is 4Bank of  $32768 \times 128 \times 16$  of cell array with the DQ pins numbered DQ0~DQ15.



# **ABSOLUTE MAXIMUM RATINGS**

| SYMBOL              | SYMBOL PARAMETER                      |                             | UNIT | NOTES |
|---------------------|---------------------------------------|-----------------------------|------|-------|
| $V_{DD}$            | Power Supply Voltage                  | -0.3~ 3.3                   | V    |       |
| $V_{DDQ}$           | Power Supply Voltage (for I/O buffer) | -0.3~V <sub>DD</sub> + 0.3  | V    |       |
| V <sub>IN</sub>     | Input Voltage                         | -0.3~V <sub>DD</sub> + 0.3  | V    |       |
| V <sub>OUT</sub>    | DQ pin Voltage                        | -0.3~V <sub>DDQ</sub> + 0.3 | V    |       |
| $V_{REF}$           | Input Reference Voltage               | -0.3~3.3                    | V    |       |
| T <sub>opr</sub>    | Operating Temperature                 | 0~70                        | °C   |       |
| T <sub>stg</sub>    | Storage Temperature                   | <b>−55~150</b>              | °C   |       |
| T <sub>solder</sub> | Soldering Temperature (10 s)          | 260                         | °C   |       |
| $P_{D}$             | Power Dissipation                     | 1                           | W    |       |
| I <sub>OUT</sub>    | OUT Short Circuit Output Current      |                             | mA   |       |

Caution: Conditions outside the limits listed under "ABSOLUTE MAXIMUM RATINGS" may cause permanent damage to the device.

The device is not meant to be operated under conditions outside the limits described in the operational section of this specification.

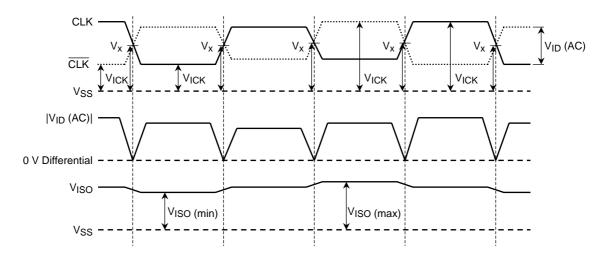
Exposure to "ABSOLUTE MAXIMUM RATINGS" conditions for extended periods may affect device reliability.

# RECOMMENDED DC, AC OPERATING CONDITIONS (Notes: 1)(Ta = 0°~70°C)

| SYMBOL                | PARAMETER  | MIN                       | TYP.                | MAX                        | UNIT | NOTES |
|-----------------------|--|---------------------------|---------------------|----------------------------|------|-------|
| $V_{DD}$              | Power Supply Voltage   | 2.35                      | 2.5                 | 2.65                       | V    |       |
| $V_{DDQ}$             | Power Supply Voltage (for I/O buffer)                                    | 2.35                      | $V_{DD}$            | $V_{DD}$                   | >    |       |
| V <sub>REF</sub>      | Input Reference Voltage  | V <sub>DDQ</sub> /2 × 96% | V <sub>DDQ</sub> /2 | V <sub>DDQ</sub> /2 × 104% | V    | 2     |
| V <sub>IH</sub> (DC)  | Input DC High Voltage  | V <sub>REF</sub> + 0.2    | _                   | V <sub>DDQ</sub> + 0.2     | ٧    | 5     |
| V <sub>IL</sub> (DC)  | L (DC) Input DC Low Voltage  |                           | _                   | V <sub>REF</sub> – 0.2     | ٧    | 5     |
| V <sub>ICK</sub> (DC) | Differential Clock DC Input Voltage                                      | -0.1                      | _                   | V <sub>DDQ</sub> + 0.1     | ٧    | 10    |
| V <sub>ID</sub> (DC)  | Input Differential Voltage. CLK and CLK inputs (DC)                      | 0.4                       |                     | V <sub>DDQ</sub> + 0.2     | ٧    | 7, 10 |
| V <sub>IH</sub> (AC)  | Input AC High Voltage  | V <sub>REF</sub> + 0.35   | _                   | V <sub>DDQ</sub> + 0.2     | V    | 3, 6  |
| V <sub>IL</sub> (AC)  | Input AC Low Voltage   | -0.1                      | _                   | V <sub>REF</sub> - 0.35    | ٧    | 4, 6  |
| V <sub>ID</sub> (AC)  | V <sub>ID</sub> (AC) Input Differential Voltage. CLK and CLK inputs (AC) |                           | _                   | V <sub>DDQ</sub> + 0.2     | V    | 7, 10 |
| V <sub>X</sub> (AC)   | Differential AC Input Cross Point Voltage                                | V <sub>DDQ</sub> /2 – 0.2 | _                   | V <sub>DDQ</sub> /2 + 0.2  | V    | 8, 10 |
| V <sub>ISO</sub> (AC) | Differential Clock AC Middle Level                                       | V <sub>DDQ</sub> /2 – 0.2 | _                   | V <sub>DDQ</sub> /2 + 0.2  | V    | 9, 10 |

Note:

- All voltages referenced to VSS, VSSQ. (1)
- (2) VREF is expected to track variations in VDDQ DC level of the transmitting device. Peak to peak AC noise on VREF may not exceed ±2% VREF (DC).
- (3)Overshoot limit:  $V_{IH (max)} = V_{DDQ} + 0.9 V$  with a pulse width  $\leq 5$  ns.
- (4) Undershoot limit:  $V_{IL (min)} = -0.9 \text{ V}$  with a pulse width  $\leq 5 \text{ ns}$ .
- (5) VIH (DC) and VIL (DC) are levels to maintain the current logic state.
- (6)VIH (AC) and VIL (AC) are levels to change to the new logic state.
- V<sub>ID</sub> is magnitude of the difference between CLK input level and CLK input level. (7)
- (8)The value of  $V_X$  (AC) is expected to equal  $V_{DDQ}/2$  of the transmitting device.
- (9)VISO means {VICK (CLK) + VICK (CLK)} /2
- (10)Refer to the figure below.



(11)In the case of external termination, VTT (termination voltage) should be gone in the range of VREF (DC)  $\pm$  0.04 V.

## **CAPACITANCE** (V<sub>DD</sub>, V<sub>DDQ</sub> = 2.5 V, f = 1 MHz, Ta = 25°C)

| SYMBOL                       | PARAMETER                        | MIN | MAX | UNIT |
|------------------------------|----------------------------------|-----|-----|------|
| C <sub>IN</sub>              | Input pin Capacitance            | 2.5 | 4.0 | pF   |
| C <sub>INC</sub>             | Clock pin (CLK, CLK) Capacitance | 2.5 | 4.0 | pF   |
| C <sub>I/O</sub>             | I/O pin (DQ, DQS) Capacitance    | 4.0 | 6.0 | pF   |
| C <sub>NC</sub> <sup>1</sup> | NC <sup>1</sup> pin Capacitance  | _   | 1.5 | pF   |
| C <sub>NC</sub> <sup>2</sup> | NC <sup>2</sup> pin Capacitance  | 4.0 | 6.0 | pF   |

Note: These parameters are periodically sampled and not 100% tested.

The  ${\rm NC}^2$  pins have additional capacitance for adjustment of the adjacent pin capacitance. The  ${\rm NC}^2$  pins have Power and Ground clamp.



# **RECOMMENDED DC OPERATING CONDITIONS** ( $V_{DD}$ , $V_{DDQ}$ =2.5V $\pm$ 0.15V, Ta = 0°~70°C)

| SYMBOL            | PARAMETER   |     | MAX | UNIT | NOTES |       |
|-------------------|---|-----|-----|------|-------|-------|
| STIVIBOL          | FARAWLILK   | -50 | -55 | -60  | ONT   | NOTES |
| I <sub>DD1S</sub> | $\label{eq:continuous} \begin{array}{l} \text{Operating Current} \\ t_{CK} = \text{min; } I_{RC} = \text{min,} \\ \text{Read/Write command cycling,} \\ 0 \ \text{V} \leq \text{V}_{IN} \leq \text{V}_{IL} \ (\text{AC}) \ (\text{max}), \ \text{V}_{IH} \ (\text{AC}) \ (\text{min}) \leq \text{V}_{IN} \leq \text{V}_{DDQ}, \\ 1 \ \text{bank operation, Burst length} = 4, \\ \text{Address change up to 2 times during minimum } I_{RC}. \end{array}$ | 190 | 180 | 170  |       | 1, 2  |
| I <sub>DD2N</sub> |   | 40  | 40  | 35   |       | 1, 2  |
| I <sub>DD2P</sub> | $ \begin{array}{ll} \text{Standby (power down)} \ \underline{Current} \\ t_{CK} = \text{min,} \ \ \overline{CS} \ = V_{IH}, \ \ \overline{PD} \ \ = V_{IL} \ \text{(power down)}, \\ 0 \ V \leq V_{IN} \leq V_{DDQ}, \\ \text{All banks: inactive state} \\ \end{array} $   | 2   | 2   | 2    | mA    | 1, 2  |
| I <sub>DD5</sub>  | Auto-Refresh Current $t_{CK} = min$ ; $l_{REFC} = min$ , $t_{REFI} = min$ , Auto-Refresh command cycling, $0 \ V \le V_{IN} \le V_{IL}$ (AC) (max), $V_{IH}$ (AC) (min) $\le V_{IN} \le V_{DDQ}$ , Address change up to 2 times during minimum $l_{REFC}$ .   | 65  | 65  | 60   |       | 1, 2  |
| I <sub>DD6</sub>  |   | 3   | 3   | 3    |       | 2     |

| SYMBOL               |   | PARAMETER  | MIN | MAX | UNIT | NOTES |
|----------------------|---|--|-----|-----|------|-------|
| ILI                  | Input Leakage ( 0 V ≤ V <sub>IN</sub> ≤ V | Current DDQ, all other pins not under test = 0 V)                      | -5  | 5   | μА   |       |
| I <sub>LO</sub>      | Output Leakag<br>(Output disable          | e Current ed, $0 \text{ V} \le V_{OUT} \le V_{DDQ}$                    | -5  | 5   | μΑ   |       |
| I <sub>REF</sub>     | V <sub>REF</sub> Current                  |  | -5  | 5   | μΑ   |       |
| I <sub>OH</sub> (DC) | Normal                                    | Output Source DC Current<br>V <sub>OH</sub> = V <sub>DDQ</sub> - 0.4 V | -10 | _   |      | 3     |
| I <sub>OL</sub> (DC) | Output Driver                             | Output Sink DC Current<br>V <sub>OL</sub> = 0.4 V                      | 10  | _   |      | 3     |
| I <sub>OH</sub> (DC) | Strong Output                             | Output Source DC Current<br>V <sub>OH</sub> = V <sub>DDQ</sub> - 0.4 V | -11 | _   |      | 3     |
| I <sub>OL</sub> (DC) | Driver                                    | Output Sink DC Current<br>V <sub>OL</sub> = 0.4 V                      | 11  | _   | mA   | 3     |
| I <sub>OH</sub> (DC) | Weaker                                    | Output Source DC Current<br>V <sub>OH</sub> = V <sub>DDQ</sub> - 0.4 V | -8  | _   | IIIA | 3     |
| I <sub>OL</sub> (DC) | Output Driver                             | Output Sink DC Current<br>V <sub>OL</sub> = 0.4 V                      | 8   | _   |      | 3     |
| I <sub>OH</sub> (DC) | Weakest                                   | Output Source DC Current<br>VOH = VDDQ - 0.4 V                         | -7  | _   |      | 3     |
| I <sub>OL</sub> (DC) | Output Driver                             | Output Sink DC Current<br>V <sub>OL</sub> = 0.4 V                      | 7   | _   |      | 3     |

Notes: 1. These parameters depend on the cycle rate and these values are measured at a cycle rate with the minimum values of  $t_{CK}$ ,  $t_{RC}$  and  $t_{RC}$ .

- 2. These parameters define the current between  $V_{DD}$  and  $V_{SS}$ .
- 3. Refer to output driver characteristics for the detail. Output Driver Strength is selected by Extended Mode Register.



# AC CHARACTERISTICS AND OPERATING CONDITIONS (Notes: 1, 2)

| 0) (1 4 7 0 1       |  |                    | -5   | 50                             | {  | 55                             | -6   | 60                             |      |       |
|---------------------|--|--------------------|--|--------------------------------|--|--------------------------------|--|--------------------------------|------|-------|
| SYMBOL              | PARAMETER  |                    | MIN  | MAX                            | MIN  | MAX                            | MIN  | MAX                            | UNIT | NOTES |
| t <sub>RC</sub>     | Random Cycle Time  |                    | 25   | _                              | 27.5                                       | _                              | 30   | _                              |      | 3     |
|                     | Clark Cyala Time   | C <sub>L</sub> = 3 | 5.5  | 8.5                            | 6  | 12                             | 6.5  | 12                             |      | 3     |
| tCK                 | Clock Cycle Time   | C <sub>L</sub> = 4 | 5  | 8.5                            | 5.5  | 12                             | 6  | 12                             |      | 3     |
| t <sub>RAC</sub>    | Random Access Time   |                    | _  | 22                             | _  | 24                             | _  | 26                             |      | 3     |
| t <sub>CH</sub>     | Clock High Time  |                    | $0.45 \times t_{CK}$                       | _                              | $0.45 \times t_{CK}$                       | _                              | $0.45 \times t_{CK}$                       | _                              |      | 3     |
| t <sub>CL</sub>     | Clock Low Time   |                    | $0.45 \times t_{CK}$                       | _                              | $0.45 \times t_{CK}$                       | _                              | $0.45 \times t_{CK}$                       | _                              |      | 3     |
| t <sub>CKQS</sub>   | DQS Access Time from 0   | CLK                | -0.65                                      | 0.65                           | -0.75                                      | 0.75                           | -0.85                                      | 0.85                           |      | 3, 8  |
| t <sub>QSQ</sub>    | Data Output Skew from I  | oqs                | _  | 0.4                            | _  | 0.45                           | _  | 0.5                            |      | 4     |
| t <sub>AC</sub>     | Data Access Time from 0  | CLK                | -0.65                                      | 0.65                           | -0.75                                      | 0.75                           | -0.85                                      | 0.85                           |      | 3, 8  |
| tOH                 | Data Output Hold Time f  | rom CLK            | -0.65                                      | 0.65                           | -0.75                                      | 0.75                           | -0.85                                      | 0.85                           |      | 3, 8  |
| t <sub>QSPRE</sub>  | DQS (read) Preamble Pu<br>Width  | ılse               | 0.9 × t <sub>CK</sub><br>- 0.2             | 1.1 × t <sub>CK</sub><br>+ 0.2 | 0.9 × t <sub>CK</sub><br>- 0.2             | 1.1 × t <sub>CK</sub><br>+ 0.2 | 0.9 × t <sub>CK</sub><br>- 0.2             | 1.1 × t <sub>CK</sub><br>+ 0.2 |      | 3, 8  |
| t <sub>HP</sub>     | CLK half period (minimum<br>Actual t <sub>CH</sub> , t <sub>CL</sub> ) | m of               | min(t <sub>CH</sub> ,<br>t <sub>CL</sub> ) | _                              | min(t <sub>CH</sub> ,<br>t <sub>CL</sub> ) | _                              | min(t <sub>CH</sub> ,<br>t <sub>CL</sub> ) | _                              |      | 3     |
| t <sub>QSP</sub>    | DQS (read) Pulse Width   |                    | t <sub>HP</sub> -<br>0.55                  |                                | t <sub>HP</sub> 0.6                        |                                | t <sub>HP</sub> -<br>0.65                  | _                              |      | 4, 8  |
| tQSQV               | Data Output Valid Time f   | rom DQS            | t <sub>HP</sub> -<br>0.55                  | _                              | t <sub>HP</sub> - 0.6                      | _                              | t <sub>HP</sub> -<br>0.65                  | _                              |      | 4, 8  |
| tDQSS               | DQS (write) Low to High S<br>Time                                      | Setup              | 0.75 × t <sub>CK</sub>                     | 1.25 × t <sub>CK</sub>         | $0.75 \times t_{CK}$                       | 1.25 × t <sub>CK</sub>         | $0.75 \times t_{CK}$                       | 1.25 × t <sub>CK</sub>         |      | 3     |
| t <sub>DSPRE</sub>  | DQS (write) Preamble Pu  | lse Width          | $0.4 \times t_{CK}$                        |                                | $0.4 \times t_{\text{CK}}$                 |                                | $0.4 \times t_{\text{CK}}$                 | _                              |      | 4     |
| t <sub>DSPRES</sub> | DQS First Input Setup Ti   | me                 | 0  |                                | 0  |                                | 0  | _                              | ne   | 3     |
| t <sub>DSPREH</sub> | DQS First Low Input Hold Time  |                    | $0.25 \times t_{\text{CK}}$                |                                | $0.25 \times t_{CK}$                       |                                | $0.25 \times t_{\text{CK}}$                | _                              | ns   | 3     |
| t <sub>DSP</sub>    | DQS High or Low Input Po   | ulse Width         | $0.45 \times t_{\text{CK}}$                | $0.55 \times t_{\text{CK}}$    | $0.45 \times t_{CK}$                       | $0.55 \times t_{\text{CK}}$    | $0.45 \times t_{CK}$                       | $0.55 \times t_{CK}$           |      | 4     |
| t <sub>DSS</sub>    | DQS Input Falling Edge<br>to Clock Setup Time                          | C <sub>L</sub> = 3 | 1.3  | _                              | 1.4  | _                              | 1.5  | _                              |      | 3, 4  |
|                     | to Glock Octup Time  | $C_L = 4$          | 1.3  | _                              | 1.4  | _                              | 1.5  | _                              |      | 3, 4  |
| t <sub>DSPST</sub>  | DQS (write) Postamble Pu   | ulse Width         | $0.45 \times t_{CK}$                       | _                              | $0.45 \times t_{CK}$                       | _                              | $0.45 \times t_{CK}$                       | _                              |      | 4     |
| tDSPSTH             | DQS (write) Postamble  | C <sub>L</sub> = 3 | 1.3  | _                              | 1.4  | _                              | 1.5  | _                              |      | 3, 4  |
| -501 0111           | Hold Time  | $C_L = 4$          | 1.3  | _                              | 1.4  | _                              | 1.5  | _                              |      | 3, 4  |
| t <sub>DSSK</sub>   | UDQS - LDQS Skew (x1   | 6)                 | -0.5 × t <sub>CK</sub>                     | $0.5 \times t_{CK}$            | -0.5 × t <sub>CK</sub>                     | $0.5 \times t_{CK}$            | $-0.5 \times t_{CK}$                       | $0.5 \times t_{CK}$            |      |       |
| t <sub>DS</sub>     | Data Input Setup Time from   | om DQS             | 0.5  | _                              | 0.5  |                                | 0.6  | _                              |      | 4     |
| tDH                 | Data Input Hold Time from  | DQS                | 0.5  | _                              | 0.5  | _                              | 0.6  | _                              |      | 4     |
| t <sub>DIPW</sub>   | Data Input Pulse Width (for each device)                               |                    | 1.5  | _                              | 1.5  | _                              | 1.9  | _                              |      |       |
| t <sub>IS</sub>     | Command/Address Input Setup Time                                       |                    | 0.9  | _                              | 0.9  | _                              | 1.0  | _                              |      | 3     |
| t <sub>IH</sub>     | Command/Address Input Hold Time  |                    | 0.9  | _                              | 0.9  | _                              | 1.0  |                                |      | 3     |
| t <sub>IPW</sub>    | Command/Address Input<br>Width (for each device)                       | t Pulse            | 2.0  | _                              | 2.0  | _                              | 2.2  | _                              |      |       |
| t <sub>LZ</sub>     | Data-out Low Impedance from CLK  | e Time             | -0.65                                      | _                              | -0.75                                      | _                              | -0.85                                      | _                              |      | 3,6,8 |
| t <sub>HZ</sub>     | Data-out High Impedance from CLK                                       | e Time             | _  | 0.65                           | _  | 0.75                           | _  | 0.85                           |      | 3,7,8 |



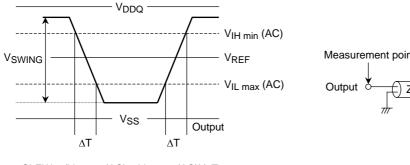
# AC CHARACTERISTICS AND OPERATING CONDITIONS (Notes: 1, 2) (continued)

| CVMDOL            | DADAMETED  |                     | -5                   | 0    | -55                  |      | -6                   | 60   | LINUT | NOTES |
|-------------------|--|---------------------|----------------------|------|----------------------|------|----------------------|------|-------|-------|
| SYMBOL            | PARAMETER  |                     | MIN                  | MAX  | MIN                  | MAX  | MIN                  | MAX  | UNIT  | NOTES |
| tQSLZ             | DQS-out Low Impedance from CLK                           | e Time              | -0.65                | _    | -0.75                |      | -0.85                |      |       | 3,6,8 |
| <sup>t</sup> QSHZ | DQS-out High Impedanc from CLK                           | e Time              | -0.65                | 0.65 | -0.75                | 0.75 | -0.85                | 0.85 |       | 3,7,8 |
| tQPDH             | Last output to $\overline{PD}$ High Time                 | Hold                | 0                    | _    | 0                    |      | 0                    |      | ns    |       |
| t <sub>PDEX</sub> | Power Down Exit Time                                     |                     | 2                    | _    | 2                    |      | 2                    |      |       | 3     |
| t <sub>T</sub>    | Input Transition Time                                    |                     | 0.1                  | 1    | 0.1                  | 1    | 0.1                  | 1    |       |       |
| tFPDL             | PD Low Input Window Self-Refresh Entry                   | for                 | $-0.5 \times t_{CK}$ | 5    | $-0.5 \times t_{CK}$ | 5    | $-0.5 \times t_{CK}$ | 5    |       | 3     |
| t <sub>REFI</sub> | Auto-Refresh Average In                                  | terval              | 0.4                  | 7.8  | 0.4                  | 7.8  | 0.4                  | 7.8  | 6     | 5     |
| tPAUSE            | Pause Time after Power-                                  | up                  | 200                  | _    | 200                  | _    | 200                  | _    | μS    |       |
| I <sub>RC</sub>   | Random Read/Write<br>Cycle Time                          | C <sub>L</sub> = 3  | 5                    | _    | 5                    | _    | 5                    | _    |       |       |
| irc               | (applicable to same bank)                                | $C_L = 4$           | 5                    | _    | 5                    | _    | 5                    | _    |       |       |
| I <sub>RCD</sub>  | RDA/WRA to LAL Comm<br>Delay<br>(applicable to same bank |                     | 1                    | 1    | 1                    | 1    | 1                    | 1    |       |       |
|                   | LAL to RDA/WRA<br>Command Input Delay                    | C <sub>L</sub> = 3  | 4                    | _    | 4                    | _    | 4                    | _    |       |       |
| I <sub>RAS</sub>  | (applicable to same bank)                                | C <sub>L</sub> = 4  | 4                    | _    | 4                    | _    | 4                    | _    |       |       |
| I <sub>RBD</sub>  | Random Bank Access De (applicable to other bank          |                     | 2                    | _    | 2                    | _    | 2                    | _    |       |       |
| I <sub>RWD</sub>  | LAL following RDA to<br>WRA Delay                        | B <sub>L</sub> = 2  | 2                    | _    | 2                    | _    | 2                    | _    |       |       |
| ·KWD              | (applicable to other bank)                               | $B_L = 4$           | 3                    | _    | 3                    | _    | 3                    | _    |       |       |
| I <sub>WRD</sub>  | LAL following WRA to RI (applicable to other bank        | •                   | 1                    | _    | 1                    |      | 1                    |      | cycle |       |
| Inco              | Mode Register Set  | C <sub>L</sub> = 3  | 5                    | _    | 5                    |      | 5                    |      |       |       |
| I <sub>RSC</sub>  | Cycle Time   | C <sub>L</sub> = 4  | 5                    | _    | 5                    | _    | 5                    | _    |       |       |
| I <sub>PD</sub>   | PD Low to Inactive State                                 | e of Input          | _                    | 1    | _                    | 1    | _                    | 1    |       |       |
| I <sub>PDA</sub>  | PD High to Active State Buffer                           | of Input            | _                    | 1    | _                    | 1    | _                    | 1    |       |       |
| I <sub>PDV</sub>  | Power down mode valid from REF command                   | C <sub>L</sub> = 3  | 15                   | _    | 15                   | _    | 15                   | _    |       |       |
|                   |  | C <sub>L</sub> = 4  | 18                   |      | 18                   | _    | 18                   | _    | =     |       |
| I <sub>REFC</sub> | Auto-Refresh Cycle<br>Time                               | $C_L = 3$ $C_L = 4$ | 15<br>18             |      | 15<br>18             | _    | 15<br>18             | _    |       |       |
| I <sub>CKD</sub>  | REF Command to Clock<br>Disable at Self-Refresh E        |                     | 16                   | _    | 16                   | _    | 16                   | _    |       |       |
| I <sub>LOCK</sub> | DLL Lock-on Time (appli<br>RDA command)                  | cable to            | 200                  | _    | 200                  | _    | 200                  | _    |       |       |

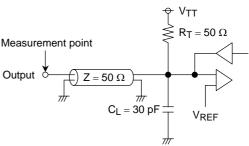


#### **AC TEST CONDITIONS**

| SYMBOL                | PARAMETER                                   | VALUE                   | UNIT | NOTES |
|-----------------------|---|-------------------------|------|-------|
| V <sub>IH</sub> (min) | Input High Voltage (minimum)                | V <sub>REF</sub> + 0.35 | V    |       |
| V <sub>IL (max)</sub> | Input Low Voltage (maximum)                 | V <sub>REF</sub> - 0.35 | V    |       |
| V <sub>REF</sub>      | Input Reference Voltage                     | V <sub>DDQ</sub> /2     | V    |       |
| V <sub>TT</sub>       | Termination Voltage                         | V <sub>REF</sub>        | V    |       |
| V <sub>SWING</sub>    | Input Signal Peak to Peak Swing             | 1.0                     | V    |       |
| Vr                    | Differential Clock Input Reference Level    | V <sub>X</sub> (AC)     | V    |       |
| V <sub>ID</sub> (AC)  | Input Differential Voltage                  | 1.5                     | V    |       |
| SLEW                  | Input Signal Minimum Slew Rate              | 1.0                     | V/ns |       |
| V <sub>OTR</sub>      | Output Timing Measurement Reference Voltage | V <sub>DDQ</sub> /2     | V    |       |



 $SLEW = (V_{IH \ min} \ (AC) - V_{IL \ max} \ (AC))/\Delta T$ 



#### AC Test Load

#### Note:

- (1) Transition times are measured between  $V_{IH\ min}$  (DC) and  $V_{IL\ max}$  (DC). Transition (rise and fall) of input signals have a fixed slope.
- (2) If the result of nominal calculation with regard to  $t_{CK}$  contains more than one decimal place, the result is rounded up to the nearest decimal place. (i.e.,  $t_{DQSS} = 0.75 \times t_{CK}$ ,  $t_{CK} = 5$  ns,  $0.75 \times 5$  ns = 3.75 ns is rounded up to 3.8 ns.)
- (3) There parameters are measured from the differential clock (CLK and  $\overline{\text{CLK}}$ ) AC cross point.
- (4) These parameters are measured from signal transition point of DQS crossing VREF level.
- (5) Te trefi (max) applies to equally distributed refresh method. The trefi (min) applies to both burst refresh method and distribted refresh method. In such case, the average interval of eight consecutive Auto-Refresh commands has to be more than 400 ns always. In other words, the number of Auto-Refresh cycles which can be performed within 3.2  $\mu$ s (8 × 400 ns) is to 8 times in the maximum.
- (6) Low Impedance State is specified at  $V_{DDQ}/2 \pm 0.2 \text{ V}$  from steady state.
- (7) High Impedance State is specified where output buffer is no longer driven.
- (8) These parameters depend on the clock jitter. These parameters are measured at stable clock.

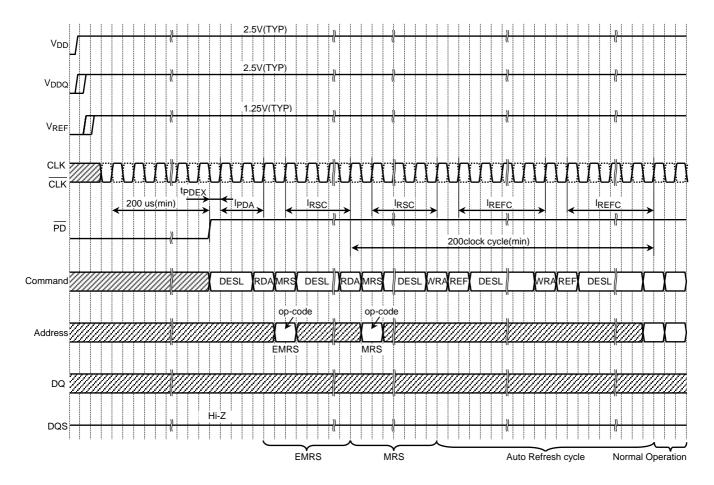


# **POWER UP SEQUENCE**

- (1) As for  $\overline{PD}$ , being maintained by the low state ( $\leq 0.2 \text{ V}$ ) is desirable before a power-supply injection.
- (2) Apply V<sub>DD</sub> before or at the same time as V<sub>DDQ</sub>.
- (3) Apply  $V_{DDQ}$  before or at the same time as  $V_{REF}$ .
- (4) Start clock (CLK,  $\overline{\text{CLK}}$ ) and maintain stable condition for 200  $\mu s$  (min).
- (5) After stable power and clock, apply DESL and take  $\overline{PD} = H$ .
- (6) Issue EMRS to enable DLL and to define driver strength. (Note: 1)
- (7) Issue MRS for set  $\overline{\text{CAS}}$  latency (CL), Burst Type (BT), and Burst Length (BL). (Note: 1)
- (8) Issue two or more Auto-Refresh commands (Note: 1).
- (9) Ready for normal operation after 200 clocks from Extended Mode Register programming.

#### Note:

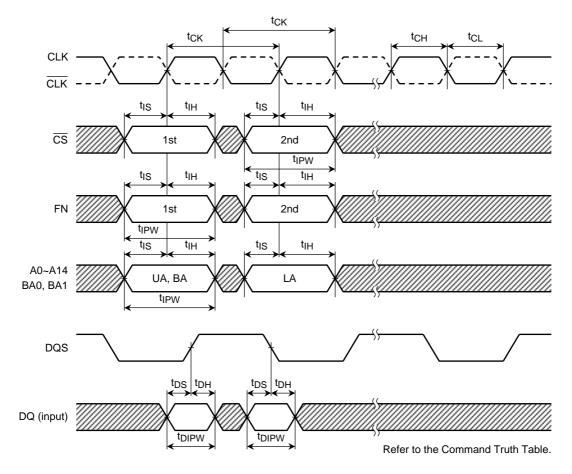
- (1) Sequence 6, 7 and 8 can be issued in random order.
- (2) L = Logic Low, H = Logic High



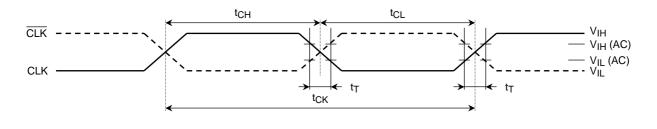


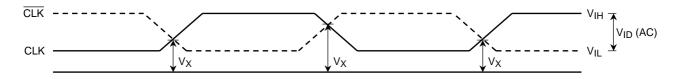
# **TIMING DIAGRAMS**

# **Input Timing**



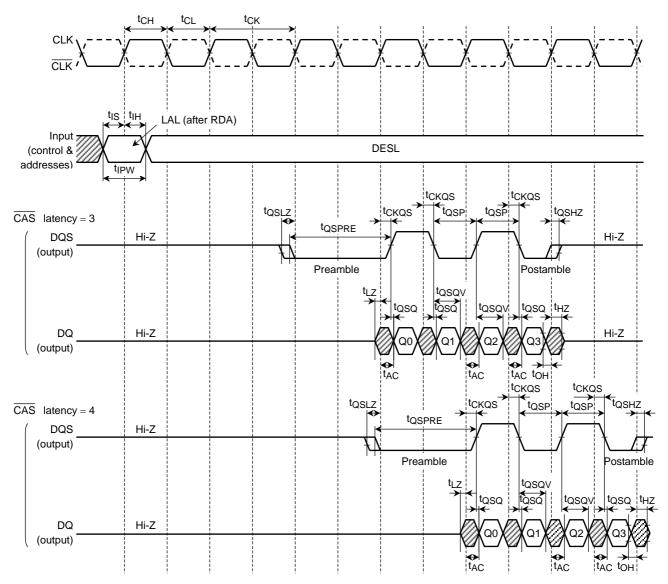
# Timing of the CLK, CLK







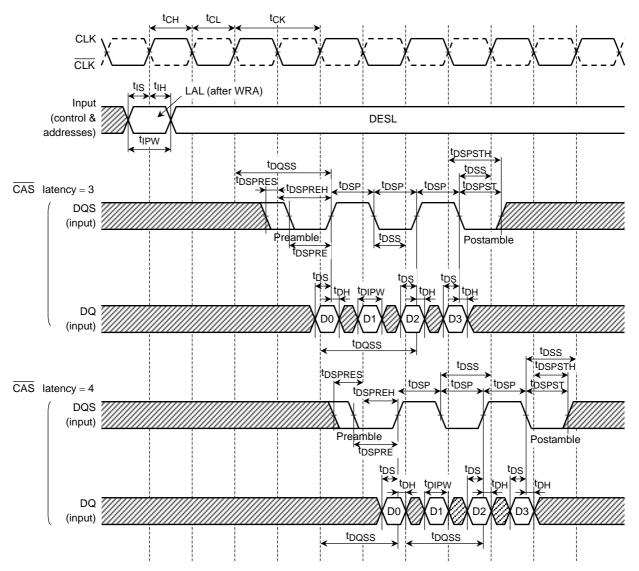
## Read Timing (Burst Length = 4)



Note: The correspondence of LDQS, UDQS to DQ. (TC59LM814CFT)

| LDQS | DQ0~DQ7  |
|------|----------|
| UDQS | DQ8~DQ15 |

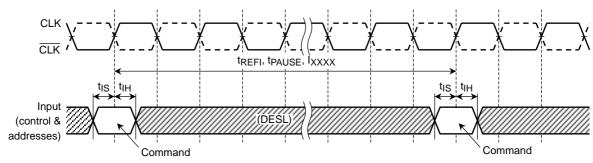
#### Write Timing (Burst Length = 4)



Note: the correspondence of LDQS, UDQS to DQ. (TC59LM814CFT)

| LDQS | DQ0~DQ7  |
|------|----------|
| UDQS | DQ8~DQ15 |

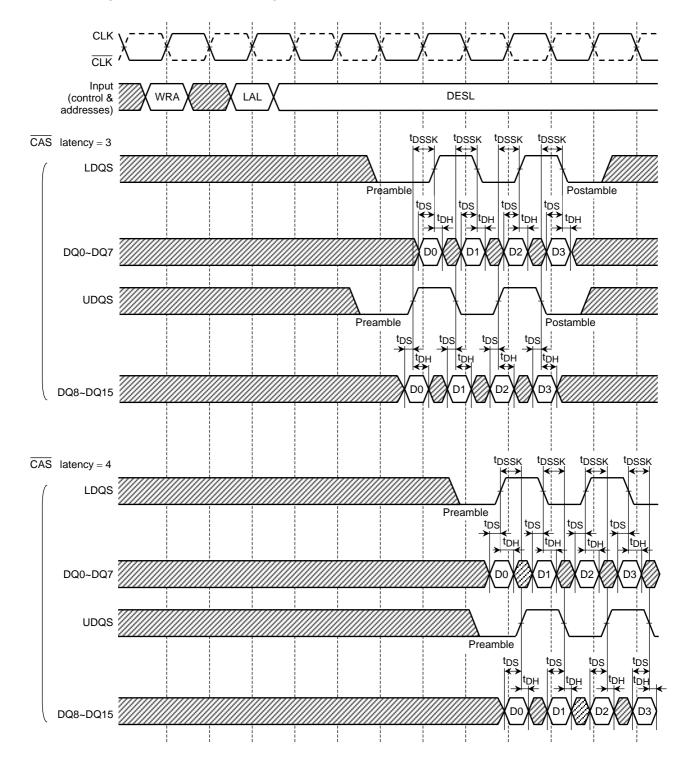
#### trefi, tpause, Ixxxx Timing



Note: "I\_XXXX" means "I\_RC", "I\_RCD", "I\_RAS", etc.



## Write Timing (x16 device) (Burst Length = 4)





# FUNCTION TRUTH TABLE (Notes: 1, 2, 3)

Command Truth Table (Notes: 4)

#### • The First Command

| SYMBOL | FUNCTION              | <del>CS</del> | FN | BA1~BA0 | A14~A9 | A8 | A7 | A6~A0 |
|--------|-----------------------|---------------|----|---------|--------|----|----|-------|
| DESL   | Device Deselect       | Н             | ×  | ×       | ×      | ×  | ×  | ×     |
| RDA    | Read with Auto-close  | L             | Н  | ВА      | UA     | UA | UA | UA    |
| WRA    | Write with Auto-close | L             | L  | ВА      | UA     | UA | UA | UA    |

#### • The Second Command (The next clock of RDA or WRA command)

| SYMBOL | FUNCTION                  | CS | FN | BA1~<br>BA0 | A14~<br>A13 | A12~<br>A11 | A10~A9 | A8 | A7 | A6~A0 |
|--------|---------------------------|----|----|-------------|-------------|-------------|--------|----|----|-------|
| LAL    | Lower Address Latch (×16) | Н  | ×  | ×           | ٧           | ٧           | ×      | ×  | ×  | LA    |
| LAL    | Lower Address Latch (×8)  | Н  | ×  | ×           | ٧           | ×           | ×      | ×  | LA | LA    |
| REF    | Auto-Refresh              | L  | ×  | ×           | ×           | ×           | ×      | ×  | ×  | ×     |
| MRS    | Mode Register Set         | L  | ×  | V           | L           | L           | L      | L  | V  | V     |

- Notes: 1. L = Logic Low, H = Logic High, × = either L or H, V = Valid (specified value), BA = Bank Address, UA = Upper Address, LA = Lower Address
  - 2. All commands are assumed to issue at a valid state.
  - 3. All inputs for command (excluding SELFX and PDEX) are latched on the crossing point of differential clock input where CLK goes to High.
  - 4. Operation mode is decided by the combination of 1st command and 2nd command. Refer to "STATE DIAGRAM" and the command table below.

#### **Read Command Table**

| COMMAND (SYMBOL) | CS | FN | BA1~BA0 | A14~A9 | A8 | A7 | A6~A0 | NOTES |
|------------------|----|----|---------|--------|----|----|-------|-------|
| RDA (1st)        | L  | Н  | ВА      | UA     | UA | UA | UA    |       |
| LAL (2nd)        | Н  | ×  | ×       | ×      | ×  | LA | LA    | 5     |

Notes: 5. For x16 device, A7 is "x" (either L or H).

# Write Command Table

#### • TC59LM814CFT

| COMMAND (SYMBOL) | cs | FN | BA1~<br>BA0 | A14  | A13  | A12  | A11  | A10~<br>A9 | A8 | A7 | A6~A0 |
|------------------|----|----|-------------|------|------|------|------|------------|----|----|-------|
| WRA (1st)        | L  | L  | ВА          | UA   | UA   | UA   | UA   | UA         | UA | UA | UA    |
| LAL (2nd)        | Н  | ×  | ×           | LVW0 | LVW1 | UVW0 | UVW1 | ×          | ×  | ×  | LA    |

#### • TC59LM806CFT

| COMMAND (SYMBOL) | <del>CS</del> | FN | BA1~<br>BA0 | A14 | A13 | A12 | A11 | A10~<br>A9 | A8 | A7 | A6~A0 |
|------------------|---------------|----|-------------|-----|-----|-----|-----|------------|----|----|-------|
| WRA (1st)        | L             | L  | ВА          | UA  | UA  | UA  | UA  | UA         | UA | UA | UA    |
| LAL (2nd)        | Н             | ×  | ×           | VW0 | VW1 | ×   | ×   | ×          | ×  | LA | LA    |

Notes: 6. A14~ A11 are used for Variable Write Length (VW) control at Write Operation.



# **FUNCTION TRUTH TABLE (continued)**

# VW Truth Table

| SYMBOL | Function              | VW0 | VW1 |
|--------|-----------------------|-----|-----|
| BL=2   | Write All Words       | L   | ×   |
| DL=2   | Write First One Word  | Н   | ×   |
|        | Reserved              | L   | L   |
| DI 4   | Write All Words       | Н   | L   |
| BL=4   | Write First Two Words | L   | Н   |
|        | Write First One Word  | Н   | Н   |

Notes: 7. For x16 device, LVW0 and LVW1 control DQ0~DQ7. UVW0 and UVW1 control DQ8~DQ15.

#### Mode Register Set Command Table

| COMMAND (SYMBOL) | cs | FN | BA1~BA0 | A14~A9 | A8 | A7 | A6~A0 | NOTES |
|------------------|----|----|---------|--------|----|----|-------|-------|
| RDA (1st)        | L  | Н  | ×       | ×      | ×  | ×  | ×     |       |
| MRS (2nd)        | L  | ×  | V       | L      | L  | V  | V     | 8     |

Notes: 8. Refer to "MODE REGISTER TABLE".

#### **Auto-Refresh Command Table**

| FUNCTION     | COMMAND   | CURRENT | P     | D | cs | FN  | BA1~BA0  | A14~A9 | A8 | A7 | A6 A0 | NOTES |
|--------------|-----------|---------|-------|---|----|-----|----------|--------|----|----|-------|-------|
| FUNCTION     | (SYMBOL)  | STATE   | n – 1 | n | CS | ΓIN | DA I~DAU | A14~A9 | Ao | A7 | A6~A0 | NOTES |
| Active       | WRA (1st) | Standby | Н     | Н | L  | L   | ×        | ×      | ×  | ×  | ×     |       |
| Auto-Refresh | REF (2nd) | Active  | Н     | Н | L  | ×   | ×        | ×      | ×  | ×  | ×     |       |

## Self-Refresh Command Table

| FUNCTION                 | COMMAND   | CURRENT      | P     | D | cs | FN  | BA1~BA0  | A14~A9 | A8 | A7 | A6~A0 | NOTES |
|--------------------------|-----------|--------------|-------|---|----|-----|----------|--------|----|----|-------|-------|
| FUNCTION                 | (SYMBOL)  | STATE        | n – 1 | n | CS | FIN | DA I~DAU | A14~A9 | Ao | A7 | Ab~AU | NOTES |
| Active                   | WRA (1st) | Standby      | Н     | Н | L  | L   | ×        | ×      | ×  | ×  | ×     |       |
| Self-Refresh Entry       | REF (2nd) | Active       | Н     | L | L  | ×   | ×        | ×      | ×  | ×  | ×     | 9, 10 |
| Self-Refresh<br>Continue | _         | Self-Refresh | L     | L | ×  | ×   | ×        | ×      | ×  | ×  | ×     |       |
| Self-Refresh Exit        | SELFX     | Self-Refresh | L     | Н | Н  | ×   | ×        | ×      | ×  | ×  | ×     | 11    |

# Power Down Table

| FUNCTION            | COMMAND  | CURRENT    | P     | D | cs | FN  | BA1~BA0  | A14~A9 | A8 | A7 | A6~A0 | NOTES |
|---------------------|----------|------------|-------|---|----|-----|----------|--------|----|----|-------|-------|
| FUNCTION            | (SYMBOL) | STATE      | n – 1 | n | CS | ΓIN | DA I~DAU | A14~A9 | Ao | A7 | A6~A0 | NOTES |
| Power Down Entry    | PDEN     | Standby    | Н     | L | Н  | ×   | ×        | ×      | ×  | ×  | ×     | 10    |
| Power Down Continue |          | Power Down | L     | L | ×  | ×   | ×        | ×      | ×  | ×  | ×     |       |
| Power Down Exit     | PDEX     | Power Down | L     | Η | Н  | ×   | ×        | ×      | ×  | ×  | ×     | 11    |

Notes: 9.  $\overline{PD}$  has to be brought to Low within t<sub>FPDL</sub> from REF command.

10.  $\overline{PD}$  should be brought to Low after DQ's state turned high impedance.

11. When  $\overline{PD}$  is brought to High from Low, this function is executed asynchronously.

**Rev 1.1** 



# **FUNCTION TRUTH TABLE** (continued)

| CURRENT STATE  | P          |        | CS | FN | ADDRESS | COMMAND         | ACTION   | NOTES  |
|--|------------|--------|----|----|---------|-----------------|--|--|
|  | n – 1<br>H | n<br>H | Н  | ×  | ×       | DESL            | NOP  |  |
|  | H          | H      | L  | H  | BA, UA  | RDA             | Row activate for Read                            |  |
|  | H          | Н.     | L  | L  | BA, UA  | WRA             | Row activate for Write                           |  |
| Idle   | Н          | L      | Н  |    |         | PDEN            | Power Down Entry                                 | 12   |
|  | H          | L      | L  | ×  | ×       | FDLIN           | Illegal  | 12   |
|  | L          |        |    |    |         | _               | Refer to Power Down State                        |  |
|  |            | ×      | ×  | ×  | ×<br>LA |                 |  |  |
|  | H          | Н      | H  | ×  |         | LAL<br>MRS/EMRS | Begin Read                                       |  |
| Row Active for Read  | H          | Н .    | L  | ×  | Op-code | PDEN            | Access to Mode Register                          |  |
| Now Active for Neau  | Н          | L      | H  | ×  | ×       |                 | Illegal  |  |
|  | H          | L      | L  | ×  | ×       | MRS/EMRS        | Illegal  |  |
|  | L          | ×      | ×  | ×  | ×       |                 | Invalid  |  |
|  | H          | Н      | Н  | ×  | LA      | LAL             | Begin Write                                      |  |
| D A .: ( )A/.:   | Н          | Н      | L  | ×  | ×       | REF             | Auto-Refresh                                     |  |
| Row Active for Write   | Н          | L      | Н  | ×  | ×       | PDEN            | Illegal  |  |
|  | Н          | L      | L  | ×  | ×       | REF (self)      | Self-Refresh Entry                               |  |
|  | L          | ×      | ×  | ×  | ×       | _               | Invalid  |  |
|  | Н          | Н      | Н  | ×  | ×       | DESL            | Continue Burst Read to End                       |  |
|  | Н          | Н      | L  | Н  | BA, UA  | RDA             | Illegal  | 13   |
| Read   | Н          | Н      | L  | L  | BA, UA  | WRA             | Illegal  | 13   |
| rtodd  | Н          | L      | Н  | ×  | ×       | PDEN            | Illegal  |  |
|  | Н          | ┙      | L  | ×  | ×       | _               | Illegal  |  |
|  | L          | ×      | ×  | ×  | ×       | _               | Invalid  |  |
|  | Н          | Н      | Н  | ×  | ×       | DESL            | Data Write&Continue Burst Write to End           |  |
|  | Н          | Н      | L  | Н  | BA, UA  | RDA             | Illegal  | 13   |
| Write  | Н          | Н      | L  | L  | BA, UA  | WRA             | Illegal  | 13   |
|  | Н          | L      | Н  | ×  | ×       | PDEN            | Illegal  |  |
|  | Н          | L      | L  | ×  | ×       | _               | Illegal  |  |
|  | L          | ×      | ×  | ×  | ×       | _               | Invalid  |  |
|  | Н          | Н      | Н  | ×  | ×       | DESL            | NOP → Idle after I <sub>REFC</sub>               |  |
|  | Н          | Н      | L  | Н  | BA, UA  | RDA             | Illegal  |  |
|  | Н          | Н      | L  | L  | BA, UA  | WRA             | Illegal  |  |
| Auto-Refreshing  | Н          | L      | Н  | ×  | ×       | PDEN            | Self-Refresh Entry                               | 14   |
|  | Н          | L      | L  | ×  | ×       | _               | Illegal  |  |
|  | L          | ×      | ×  | ×  | ×       | _               | Refer to Self-Refreshing State                   |  |
|  | Н          | Н      | Н  | ×  | ×       | DESL            | $NOP \rightarrow Idle after I_{RSC}$             |  |
|  | Н          | Н      | L  | Н  | BA, UA  | RDA             | Illegal  |  |
| Mode Register  | H          | Н      | L  | L  | BA, UA  | WRA             | Illegal  |  |
| Accessing  | H          | L      | Н  | ×  | × ×     | PDEN            | Illegal  |  |
| , and the second | Н          | L      | L  | ×  | ×       |                 | Illegal  |  |
|  | L          | ×      | ×  | ×  | ×       |                 | Invalid  |  |
|  | Н          | ×      | ×  | ×  | ×       | _               | Invalid  |  |
|  | L          | L      |    |    |         |                 | Maintain Power Down Mode                         | <del>                                     </del> |
| Power Down   |            | L      | ×  | ×  | ×       | _               | Exit Power Down Mode → Idle after                | -  |
|  | L          | Н      | H  | ×  | ×       | PDEX            | t <sub>PDEX</sub>                                |  |
|  | L          | Н      | L  | ×  | ×       | _               | Illegal  |  |
|  | Н          | ×      | ×  | ×  | ×       |                 | Invalid  |  |
|  | L          | L      | ×  | ×  | ×       |                 | Maintain Self-Refresh                            |  |
| Self-Refreshing  | L          | Н      | Н  | ×  | ×       | SELFX           | Exit Self-Refresh → Idle after I <sub>REFC</sub> |  |
|  | L          | Н      | L  | ×  | ×       | _               | Illegal  |  |
|  |            |        |    |    |         |                 |  |  |

Notes: 12. Illegal if any bank is not idle.

<sup>13.</sup> Illegal to bank in specified states; Function may be legal in the bank inidicated by Bank Address (BA).

<sup>14.</sup> Illegal if tFPDL is not satisfied.



# **MODE REGISTER TABLE**

# Regular Mode Register (Notes: 1)

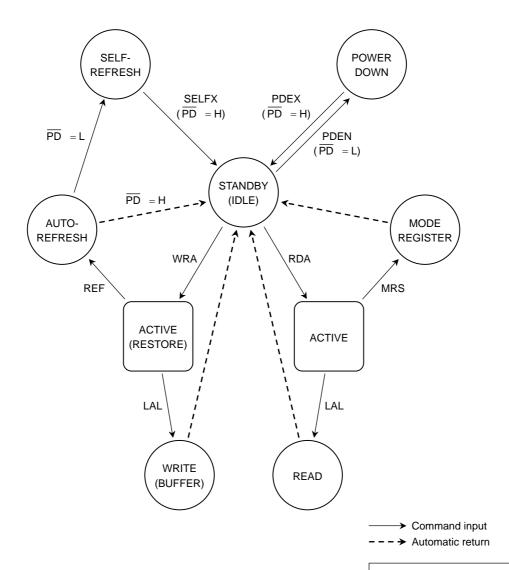
| ADDR    | ESS          |      | BA1 <sup>*1</sup>                          | BA0 <sup>*1</sup> | A14~A8 | А       | .7 <sup>*3</sup> | A6~     | A4               | А3                         |     |
|---------|--------------|------|--|-------------------|--------|---------|------------------|---------|------------------|----------------------------|-----|
| Regi    | ster         |      | 0  | 0                 | 0      | -       | TE               | Cl      | -                | ВТ                         |     |
|         | A7<br>0<br>1 | Reg  | T MODE (TE)  Jular (default)  t Mode Entry | _                 |        |         | A3 0 1           | S       | ST TYP<br>sequen |                            | /   |
|         |              |      |  |                   |        |         |                  |         |                  | /                          |     |
| A6      | A5           | A4   | CAS LATE                                   | :NCY (CL)         | Γ      | A2      | A1               | A0      | BURS             | ST LENGTH (I               | BL) |
| A6<br>0 | A5<br>0      | A4 × |  |                   | [      | A2<br>0 | A1<br>0          | A0<br>0 |                  | ·                          | BL) |
|         |              |      | CAS LATE  Reserv  Reserv                   | /ed <sup>*2</sup> |        |         |                  |         |                  | ET LENGTH (I               | BL) |
| 0       | 0            | ×    | Reserv                                     | ved <sup>*2</sup> |        | 0       | 0                | 0       |                  | Reserved*2                 | BL) |
| 0       | 0 1          | × 0  | Reserv<br>Reserv<br>3                      | ved <sup>*2</sup> |        | 0       | 0                | 0 1     | ı                | Reserved <sup>*2</sup> 2 4 | BL) |
| 0 0     | 0 1 1        | × 0  | Reserv<br>Reserv                           | ved <sup>*2</sup> |        | 0 0     | 0 0 1            | 0 1 0   | ı                | Reserved*2                 | BL) |

## Extended Mode Register (Notes: 4)

| Ext | <u>ended Mode Regis</u> | <u>ter</u> (Notes: | 4)               |                   |       |                      |              |       |           |                  |
|-----|-------------------------|--------------------|------------------|-------------------|-------|----------------------|--------------|-------|-----------|------------------|
|     | ADDRESS                 | BA1 <sup>*4</sup>  | BA0 <sup>*</sup> | BA0 <sup>*4</sup> |       | A6                   | A5~A2        |       | A1        | A0 <sup>*5</sup> |
|     | Register                | 0                  | 1                | 1                 |       | DIC                  | 0            |       | DIC       | DS               |
|     |                         |                    |                  |                   |       | <b>\</b>             |              |       | <b>\</b>  | _                |
|     |                         |                    | A6               | A <sup>2</sup>    | I OUT | PUT DRIVE IN         | MPEDANCE     | CONTR | ROL (DIC) |                  |
|     |                         |                    | 0                | 0                 |       | Norm                 | al Output Dr | iver  |           |                  |
|     |                         |                    | 0                | 1                 |       | Strong Output Driver |              |       |           |                  |
|     |                         |                    | 1                | 0                 |       | Weak                 | er Output Dr | river |           |                  |
|     |                         |                    | 1                | 1                 |       | Weak                 | est Output D | river |           |                  |
|     |                         |                    |                  |                   |       |                      | Í            |       |           | <u> </u>         |
|     |                         |                    |                  |                   |       |                      |              | A0    | DLL SV    | VITCH (DS)       |
|     |                         |                    |                  |                   |       |                      |              | 0     | DLL       | _ Enable         |
|     |                         |                    |                  |                   |       |                      |              | 1     | DLL       | . Disable        |

- Notes: 1. Regular Mode Register is chosen using the combination of BA0 = 0 and BA1 = 0.
  - 2. "Reserved" places in Regular Mode Register should not be set.
  - 3. A7 in Regular Mode Register must be set to "0" (low state). Because Test Mode is specific mode for supplier.
  - 4. Extended Mode Register is chosen using the combination of BA0 = 1 and BA1 = 0.
  - 5. A0 in Extended Mode Register must be set to "0" to enable DLL for normal operation.

# **STATE DIAGRAM**

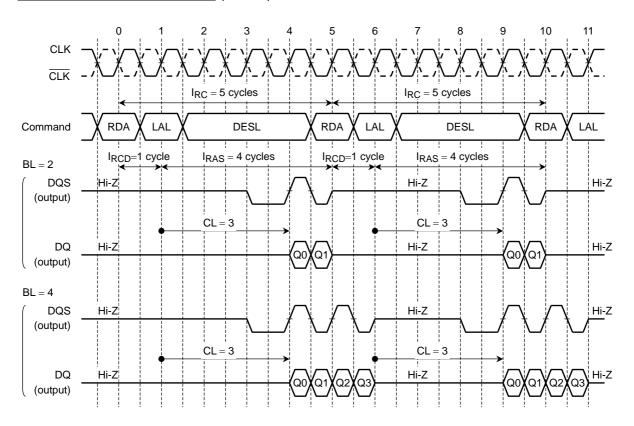


The second command at Active state must be issued 1 clock after RDA or WRA command input.

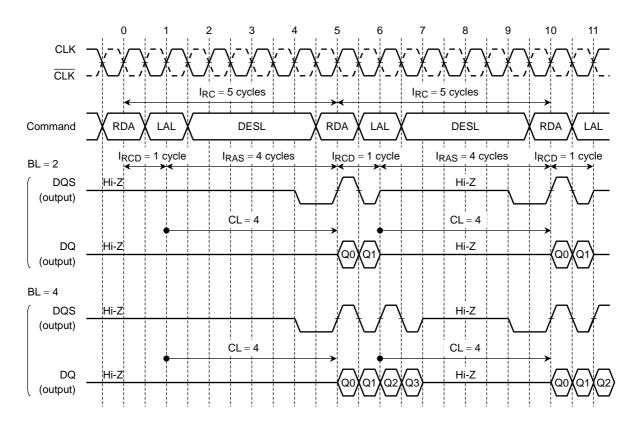


#### **TIMING DIAGRAMS**

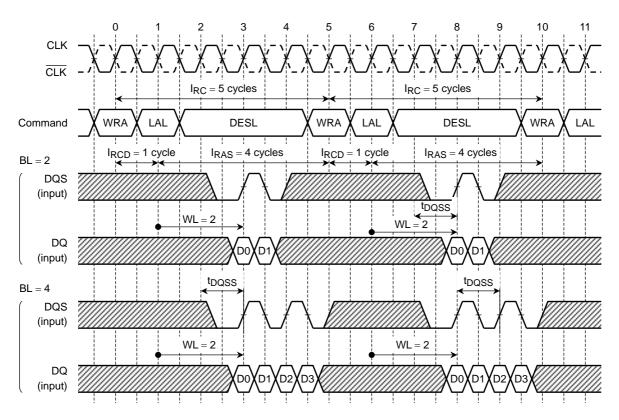
#### SINGLE BANK READ TIMING (CL = 3)



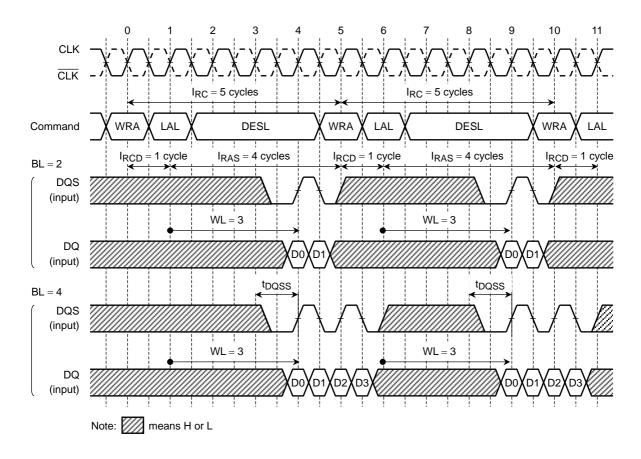
#### SINGLE BANK READ TIMING (CL = 4)



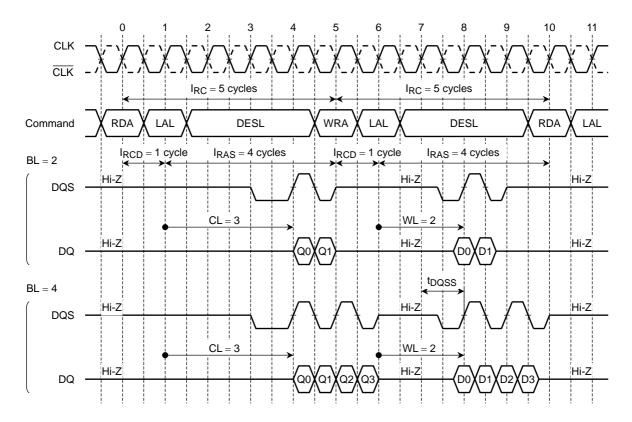
#### SINGLE BANK WRITE TIMING (CL = 3)



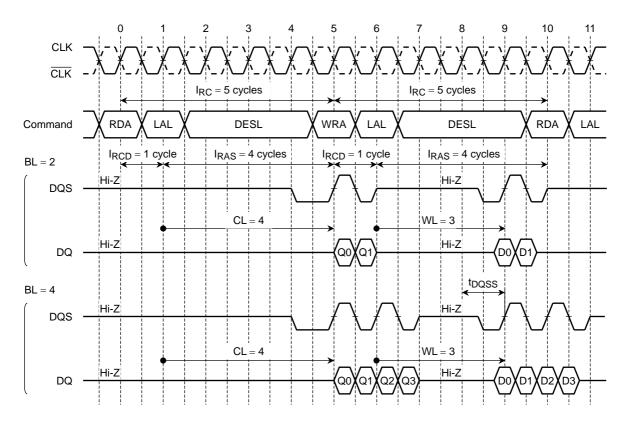
## SINGLE BANK WRITE TIMING (CL = 4)



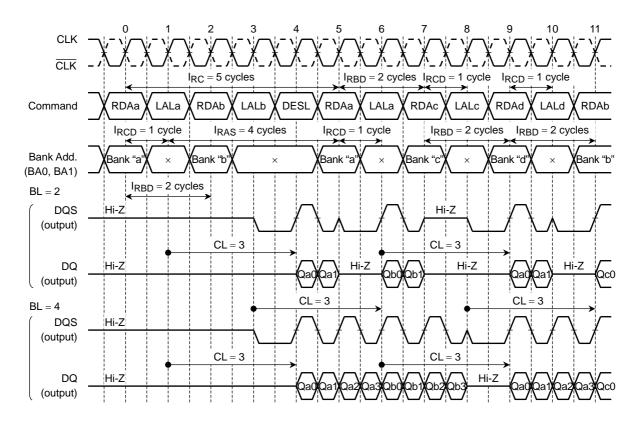
# SINGLE BANK READ-WRITE TIMING (CL = 3)



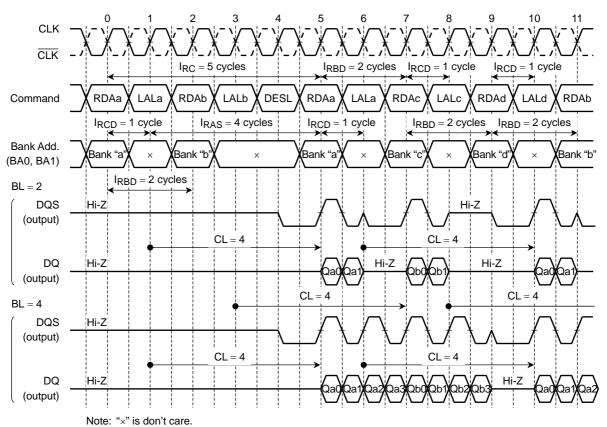
# SINGLE BANK READ-WRITE TIMING (CL = 4)



## MULTIPLE BANK READ TIMING (CL = 3)



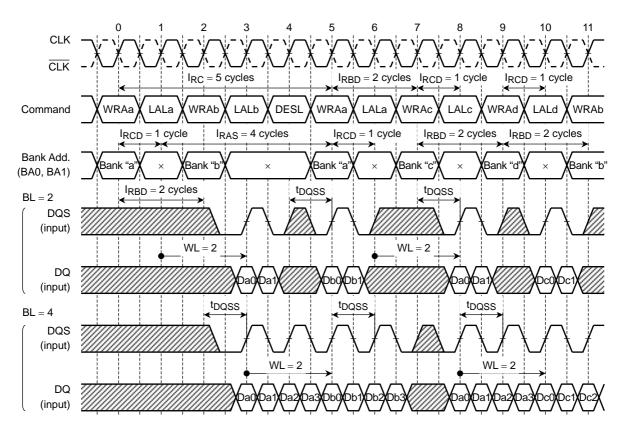
#### MULTIPLE BANK READ TIMING (CL = 4)



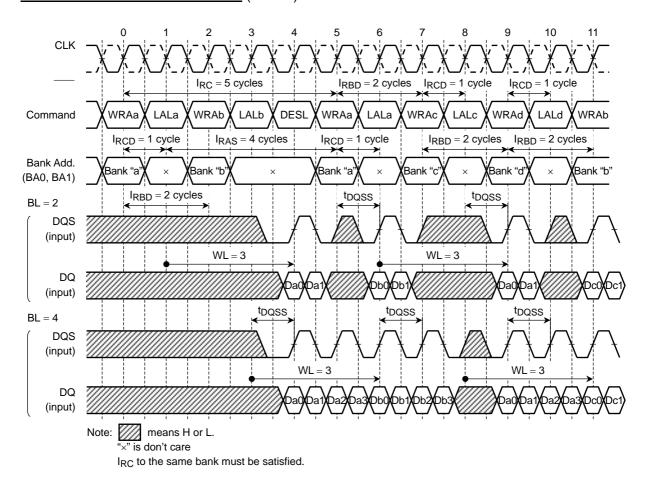
I<sub>RC</sub> to the same bank must be satisfied.



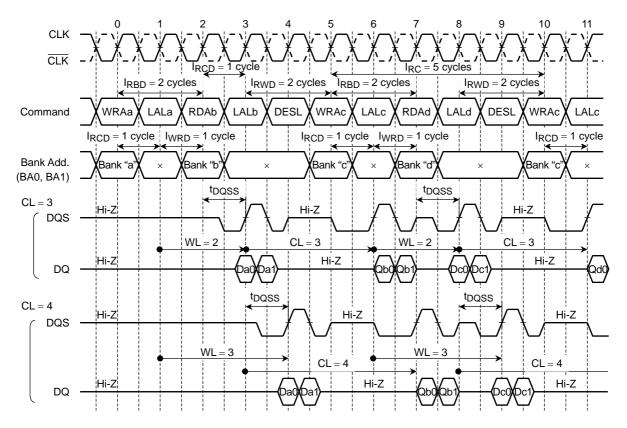
#### MULTIPLE BANK WRITE TIMING (CL = 3)



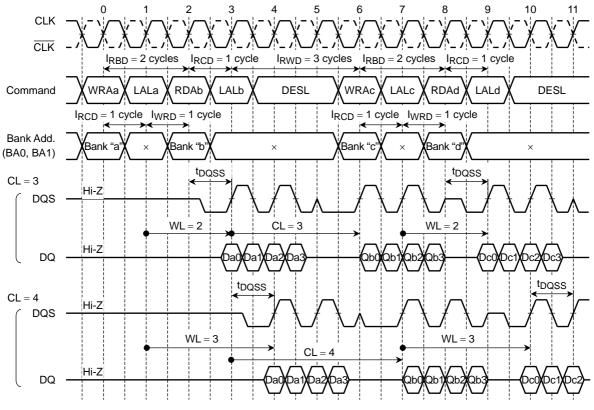
## MULTIPLE BANK WRITE TIMING (CL = 4)



## MULTIPLE BANK READ-WRITE TIMING (BL = 2)



## MULTIPLE BANK READ-WRITE TIMING (BL = 4)

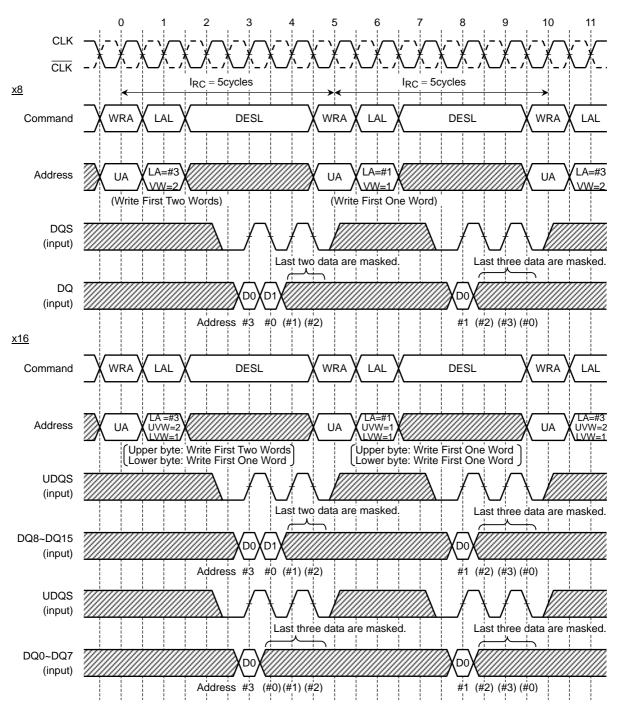


Note: "x" is don't care

I<sub>RC</sub> to the same bank must be satisfied.



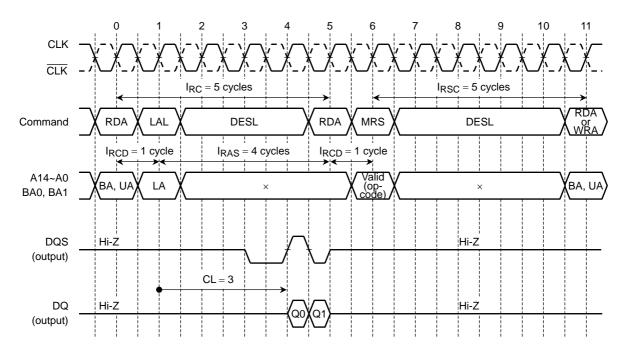
# SINGLE BANK WRITE with VARIABLE WRITE LENGTH (VW) CONTROL (CL = 3, BL = 4, Sequential mode)



Note: DQS input must be continued till end of burst count even if some of laster data is masked. Refer to "VW Truth Table".

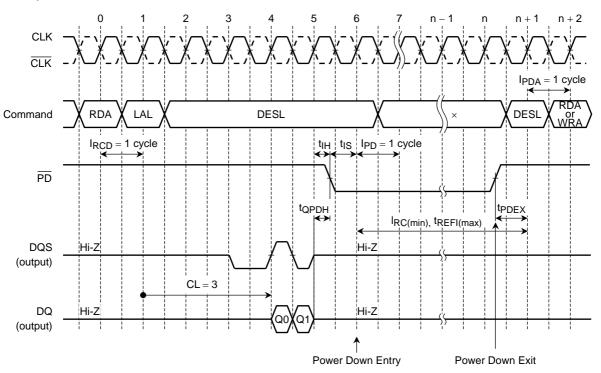


# $\underline{\mathsf{MODE}\;\mathsf{REGISTER\;\mathsf{SET\;\mathsf{TIMING}}}}\;(\mathsf{CL}=3,\,\mathsf{BL}=2)$



#### POWER DOWN TIMING (CL = 3, BL = 2)

#### Read cycle to Power Down Mode



Note: "x" is don't care

 $I_{PD}$  is defined from the first clock rising edge after  $\overline{PD}$  is brought to "Low".  $I_{PDA}$  is defined from the first clock rising edge after  $\overline{PD}$  is brought to "High".

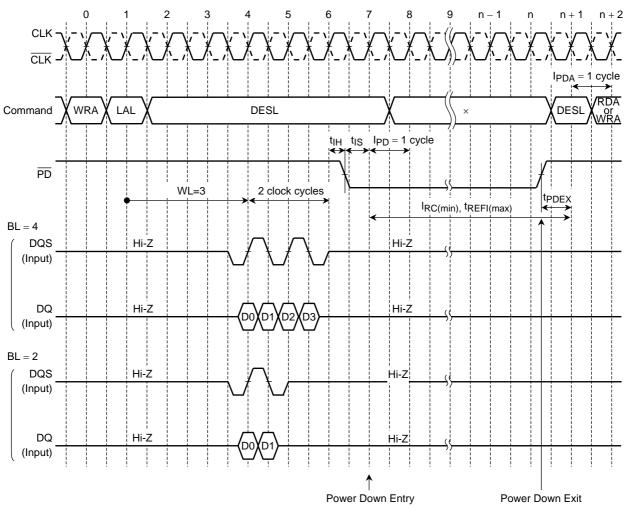
PD must be kept "High" level until end of Burst data output.

PD should be brought to high within t<sub>REFI(max)</sub> to maintain the data written into cell.



# POWER DOWN TIMING (CL = 4)

Write cycle to Power Down Mode

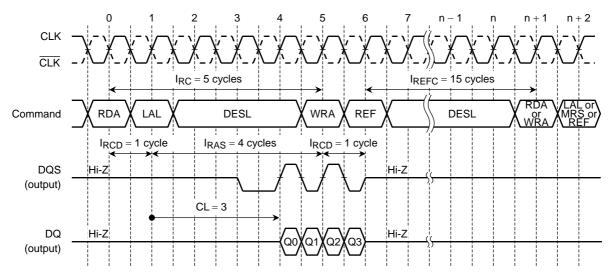


Note: "x" is care

PD must be kept "High" level until WL+2 clock cycles from LAL command.

 $\overline{\text{PD}}$  should be brought to high within  $t_{\text{REFI}(\text{max})}$  to maintain the data written into cell.

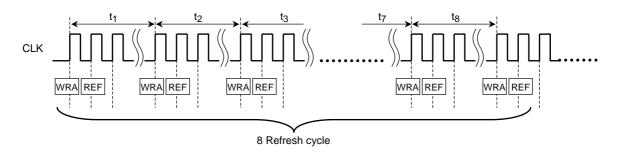
# AUTO-REFRESH TIMING (CL = 3, BL = 4)



Note: In case of CL = 3,  $I_{REFC}$  must be meet 15 clock cycles.

When the Auto-Refresh operation is performed, the synthetic average interval of Auto-Refresh command specified by t<sub>REFI</sub> must be satisfied.

t<sub>REFI</sub> is average interval time in 8 Refresh cycles that is sampled randomly.

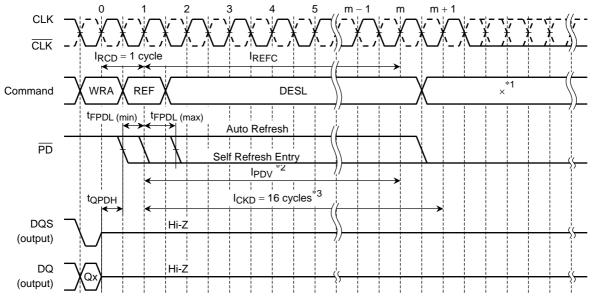


$$t_{REFI} = \frac{\text{Total time of 8 Refresh cycle}}{8} = \frac{t_1 + t_2 + t_3 + t_4 + t_5 + t_6 + t_7 + t_8}{8}$$

 $t_{\sf REFI}$  is specified to avoid partly concentrated current of Refresh operation that is activated larger area than Read / Write operation.

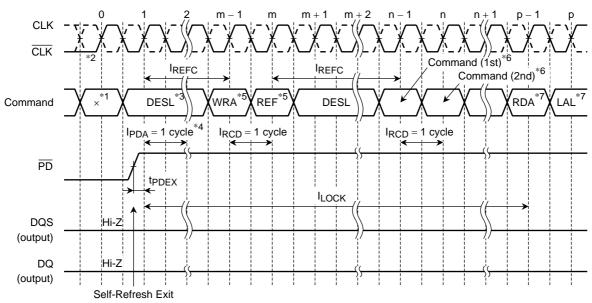


## SELF-REFRESH ENTRY TIMING (CL = 3)



- Notes: 1. "x" is don't care.
  - 2. PD must be brought to "Low" within the timing between t<sub>FPDL</sub>(min) and t<sub>FPDL</sub>(max) to Self Refresh mode.When PD is brought to "Low" after I<sub>PDV</sub>, FCRAM perform Auto Refresh and enter Power down mode.
  - 3. It is necessary that clock input is continued at least 16 clock cycles from REF command even though  $\overline{PD}$  is brought to "Low" for Self-Refresh Entry.

#### **SELF-REFRESH EXIT TIMING**



- Notes: 1. "x" is don't care.
  - 2. Clock should be stable prior to  $\overline{PD}$  = "High" if clock input is suspended in Self-Refresh mode.
  - 3. DESL command must be asserted during  $I_{REFC}$  after  $\overline{PD}$  is brought to "High".
  - 4. IPDA is defined from the first clock rising edge after PD is brought to "High".
  - It is desirable that one Auto-Refresh command is issued just after Self-Refresh Exit before any other operation.
  - 6. Any command (except Read command) can be issued after IREFC.
  - 7. Read command (RDA + LAL) can be issued after I<sub>LOCK</sub>.

## **FUNCTIONAL DESCRIPTION**

# Network FCRAM<sup>TM</sup>

The FCRAM<sup>TM</sup> is an acronym of Fast Cycle Random Access Memory. The Network FCRAM<sup>TM</sup> is competent to perform fast random core access, low latency, low consumption and high-speed data transfer.

#### **PIN FUNCTIONS**

# CLOCK INPUTS: CLK & CLK

The CLK and  $\overline{\text{CLK}}$  inputs are used as the reference for synchronous operation. CLK is master clock input. The  $\overline{\text{CS}}$ , FN and all address input signals are sampled on the crossing of the positive edge of CLK and the negative edge of  $\overline{\text{CLK}}$ . The DQS and DQ output data are referenced to the crossing point of CLK and  $\overline{\text{CLK}}$ . The timing reference point for the differential clock is when the CLK and  $\overline{\text{CLK}}$  signals cross during a transition.

#### POWER DOWN: PD

The  $\overline{PD}$  input controls the entry to the Power Down or Self-Refresh modes. The  $\overline{PD}$  input does not have a Clock Suspend function like a CKE input of a standard SDRAMs, therefore it is illegal to bring  $\overline{PD}$  pin into low state if any Read or Write operation is being performed.

## CHIP SELECT & FUNCTION CONTROL: CS & FN

The  $\overline{CS}$  and FN inputs are a control signal for forming the operation commands on FCRAM<sup>TM</sup>. Each operation mode is decided by the combination of the two consecutive operation commands using the  $\overline{CS}$  and FN inputs.

#### BANK ADDRESSES: BA0 & BA1

The BAO and BA1 inputs are latched at the time of assertion of the RDA or WRA command and are selected the bank to be used for the operation.

|         | BA0 | BA1 |
|---------|-----|-----|
| Bank #0 | 0   | 0   |
| Bank #1 | 1   | 0   |
| Bank #2 | 0   | 1   |
| Bank #3 | 1   | 1   |

#### ADDRESS INPUTS: A0~A14

Address inputs are used to access the arbitrary address of the memory cell array within each bank. The Upper Addresses with Bank addresses are latched at the RDA or WRA command and the Lower Addresses are latched at the LAL command. The A0 to A14 inputs are also used for setting the data in the Regular or Extended Mode Register set cycle.

|              | UPPER ADDRESS | LOWER ADDRESS |
|--------------|---------------|---------------|
| TC59LM806CFT | A0~A14        | A0~A7         |
| TC59LM814CFT | A0~A14        | A0~A6         |



#### DATA INPUT/OUTPUT: DQ0~DQ7 or DQ15

The input data of DQ0 to DQ15 are taken in synchronizing with the both edges of DQS input signal. The output data of DQ0 to DQ15 are outputted synchronizing with the both edges of DQS output signal.

#### DATA STROBE: DQS or LDQS, UDQS

The DQS is bi-directional signal. Both edges of DQS are used as the reference of data input or output. The LDQS is allotted for Lower Byte (DQ0 to DQ7) Data. The UDQS is allotted for Upper Byte (DQ8 to DQ15) Data. In write operation, the DQS used as an input signal is utilized for a latch of write data. In read operation, the DQS that is an output signal provides the read data strobe.

#### POWER SUPPLY: VDD, VDDQ, VSS, VSSQ

 $V_{DD}$  and  $V_{SS}$  are power supply pins for memory core and peripheral circuits.  $V_{DDQ}$  and  $V_{SSQ}$  are power supply pins for the output buffer.

#### REFERENCE VOLTAGE: VREF

VREF is reference voltage for all input signals.



#### **COMMAND FUNCTIONS and OPERATIONS**

TC59LM814/06CFT are introduced the two consecutive command input method. Therefore, except for Power Down mode, each operation mode decided by the combination of the first command and the second command from stand-by states of the bank to be accessed.

#### Read Operation (1st command + 2nd command = RDA + LAL)

Issuing the RDA command with Bank Addresses and Upper Addresses to the idle bank puts the bank designated by Bank Address in a read mode. When the LAL command with Lower Addresses is issued at the next clock of the RDA command, the data is read out sequentially synchronizing with the both edges of DQS output signal (Burst Read Operation). The initial valid read data appears after  $\overline{CAS}$  latency from the issuing of the LAL command. The valid data is outputted for a burst length. The  $\overline{CAS}$  latency, the burst length of read data and the burst type must be set in the Mode Register beforehand. The read operated bank goes back automatically to the idle state after  $l_{RC}$ .

## Write Operation (1st command + 2nd command = WRA + LAL)

Issuing the WRA command with Bank Addresses and Upper Addresses to the idle bank puts the bank designated by Bank Address in a write mode. When the LAL command with Lower Addresses is issued at the next clock of the WRA command, the input data is latched sequentially synchronizing with the both edges of DQS input signal (Burst Write Operation). The data and DQS inputs have to be asserted in keeping with clock input after  $\overline{CAS}$  latency-1 from the issuing of the LAL command. The DQS have to be provided for a burst length. The  $\overline{CAS}$  latency and the burst type must be set in the Mode Register beforehand. The write operated bank goes back automatically to the idle state after lRC.

## <u>Auto-Refresh Operation</u> (1st command + 2nd command = WRA + REF)

TC59LM814/06CFT are required to refresh like a standard SDRAM. The Auto-Refresh operation is begun with the REF command following to the WRA command. The Auto-Refresh mode can be effective only when all banks are in the idle state. In a point to notice, the write mode started with the WRA command is canceled by the REF command having gone into the next clock of the WRA command instead of the LAL command. The minimum period between the Auto-Refresh command and the next command is specified by  $l_{\rm REFC}$ . However, about a synthetic average interval of Auto-Refresh command, it must be careful. In case of equally distributed refresh, Auto-Refresh command has to be issued within once for every 7.8  $\mu s$  by the maximum. In case of burst refresh or random distributed refresh, the average interval of eight consecutive Auto-Refresh command has to be more than 400 ns always. In other words, the number of Auto-Refresh cycles which can be performed within 3.2  $\mu s$  (8  $\times$  400 ns) is to 8 times in the maximum.

# <u>Self-Refresh Operation</u> (1st command + 2nd command = WRA + REF with $\overline{PD}$ = "L")

It is the function of Self-Refresh operation that refresh operation can be performed automatically by using an internal timer. When all banks are in the idle state and all outputs are in Hi-Z states, the TC59LM814/06CFT become Self-Refresh mode by issuing the Self-Refresh command.  $\overrightarrow{PD}$  has to be brought to "Low" within tFPDL from the REF command following to the WRA command for a Self-Refresh mode entry. In order to satisfy the refresh period, the Self-Refresh entry command should be asserted within 7.8  $\mu$ s after the latest Auto-Refresh command. Once the device enters Self-Refresh mode, the DESL command must be continued for lREFC period. In addition, it is necessary that clock input is kept in lCKD period. The device is in Self-Refresh mode as long as  $\overline{PD}$  held "Low". During Self-Refresh mode, all input and output buffers except for  $\overline{PD}$  are disabled, therefore the power dissipation lowers. Regarding a Self-Refresh mode exit,  $\overline{PD}$  has to be changed over from "Low" to "High" along with the DESL command, and the DESL command has to be continuously issued in the number of clocks specified by lREFC. The Self-Refresh exit function is asynchronous operation. It is required that one Auto-Refresh command is issued to avoid the violation of the refresh period just after lREFC from Self-Refresh exit.

# Power Down Mode ( $\overline{PD} = L$ ")

When all banks are in the idle state and all outputs are in Hi-Z states, the TC59LM814/06CFT become Power Down Mode by asserting  $\overline{PD}$  is "Low". When the device enters the Power Down Mode, all input and output buffers except for  $\overline{PD}$  are disabled after specified time. Therefore, the power dissipation lowers. To exit the Power Down Mode,  $\overline{PD}$  has to be brought to "High" and the DESL command has to be issued at next CLK rising edge after  $\overline{PD}$  goes high. The Power Down exit function is asynchronous operation.

#### Mode Register Set (1st command + 2nd command = RDA + MRS)

When all banks are in the idle state, issuing the MRS command following to the RDA command can program the Mode Register. In a point to notice, the read mode started with the RDA command is canceled by the MRS command having gone into the next clock of the RDA command instead of the LAL command. The data to be set in the Mode Register is transferred using A0 to A14, BA0 and BA1 address inputs. The TC59LM814/06CFT have two mode registers. These are Regular and Extended Mode Register. The Regular or Extended Mode Register is chosen by BA0 and BA1 in the MRS command. The Regular Mode Register designates the operation mode for a read or write cycle. The Regular Mode Register has four function fields.

The four fields are as follows:

- (R-1) Burst Length field to set the length of burst data
- (R-2) Burst Type field to designate the lower address access sequence in a burst cycle
- (R-3) CAS Latency field to set the access time in clock cycle
- (R-4) Test Mode field to use for supplier only.

The Extended Mode Register has two function fields.

The two fields are as follows:

- (E-1) DLL Switch field to choose either DLL enable or DLL disable
- (E-2) Output Driver Impedance Control field.

Once those fields in the Mode Register are set up, the register contents are maintained until the Mode Register is set up again by another MRS command or power supply is lost. The initial value of the Regular or Extended Mode Register after power-up is undefined, therefore the Mode Register Set command must be issued before proper operation.



Regular Mode Register/Extended Mode Register change bits (BA0, BA1)
 These bits are used to choose either Regular MRS or Extended MRS

| BA1 | BA0 | Mode Register Set |
|-----|-----|-------------------|
| 0   | 0   | Regular MRS       |
| 0   | 1   | Extended MRS      |
| 1   | ×   | Reserved          |

#### Regular Mode Register Fields

#### (R-1) Burst Length field (A2 to A0)

This field specifies the data length for column access using the A2 to A0 pins and sets the Burst Length to be 2 or 4 words.

| A2 | A1 | A0 | BURST LENGTH |
|----|----|----|--------------|
| 0  | 0  | 0  | Reserved     |
| 0  | 0  | 1  | 2 words      |
| 0  | 1  | 0  | 4 words      |
| 0  | 1  | 1  | Reserved     |
| 1  | ×  | ×  | Reserved     |

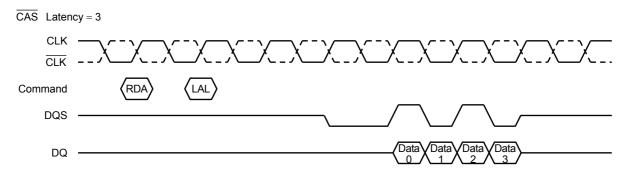
#### (R-2) Burst Type field (A3)

The Burst Type can be chosen Interleave mode or Sequential mode. When the A3 bit is "0", Sequential mode is selected. When the A3 bit is "1", Interleave mode is selected. Both burst types support burst length of 2 and 4 words.

| A3 | BURST TYPE |
|----|------------|
| 0  | Sequential |
| 1  | Interleave |

• Addressing sequence of Sequential mode (A3)

A column access is started from the inputted lower address and is performed by incrementing the lower address input to the device. The address is varied by the Burst Length as the following.



#### Addressing sequence for Sequential mode

| DATA   | ACCESS ADDRESS | BURST LENGTH  |
|--------|----------------|---|
| Data 0 | n              | 2 words (address bits is LA0)                               |
| Data 1 | n + 1          | not carried from LA0~LA1                                    |
| Data 2 | n + 2          | 4 words (address bits is LA1, LA0) not carried from LA1~LA2 |
| Data 3 | n + 3          | )   |



• Addressing sequence of Interleave mode

A column access is started from the inputted lower address and is performed by interleaving the address bits in the sequence shown as the following.

#### Addressing sequence for Interleave mode

| DATA   |    |    | A  | CCE | SS A | DDR | ESS |    |    | BURST LENGTH |
|--------|----|----|----|-----|------|-----|-----|----|----|--------------|
| Data 0 | A8 | A7 | A6 | A5  | A4   | А3  | A2  | A1 | A0 | 2 words      |
| Data 1 | A8 | A7 | A6 | A5  | A4   | А3  | A2  | A1 | Ā0 |              |
| Data 2 | A8 | A7 | A6 | A5  | A4   | А3  | A2  | Ā1 | A0 | 4 words      |
| Data 3 | A8 | A7 | A6 | A5  | A4   | А3  | A2  | Ā1 | Ā0 | J            |

(R-3)  $\overline{\text{CAS}}$  Latency field (A6 to A4)

This field specifies the number of clock cycles from the assertion of the LAL command following the RDA command to the first data read. The minimum values of  $\overline{CAS}$  Latency depends on the frequency of CLK. In a write mode, the place of clock which should input write data is  $\overline{CAS}$  Latency cycles – 1.

| A6 | A5 | A4 | CAS LATENCY |
|----|----|----|-------------|
| 0  | 0  | 0  | Reserved    |
| 0  | 0  | 1  | Reserved    |
| 0  | 1  | 0  | Reserved    |
| 0  | 1  | 1  | 3           |
| 1  | 0  | 0  | 4           |
| 1  | 0  | 1  | Reserved    |
| 1  | 1  | 0  | Reserved    |
| 1  | 1  | 1  | Reserved    |

(R-4) Test Mode field (A7)

This bit is used to enter Test Mode for supplier only and must be set to "0" for normal operation.

- (R-5) Reserved field in the Regular Mode Register
  - Reserved bits (A8 to A14)

These bits are reserved for future operations. They must be set to "0" for normal operation.

#### Extended Mode Register fields

(E-1) DLL Switch field (A0)

This bit is used to enable DLL. When the A0 bit is set "0", DLL is enabled.

(E-2) Output Driver Impedance Control field (A1 / A6)

This bit is used to choose Output Driver Strength. Four types of Driver Strength are supported.

| A6 | A1 | OUTPUT DRIVER IMPEDANCE CONTROL |  |
|----|----|---------------------------------|--|
| 0  | 0  | Normal Output Driver            |  |
| 0  | 1  | Strong Output Driver            |  |
| 1  | 0  | Weaker Output Driver            |  |
| 1  | 1  | Weakest Output Driver           |  |

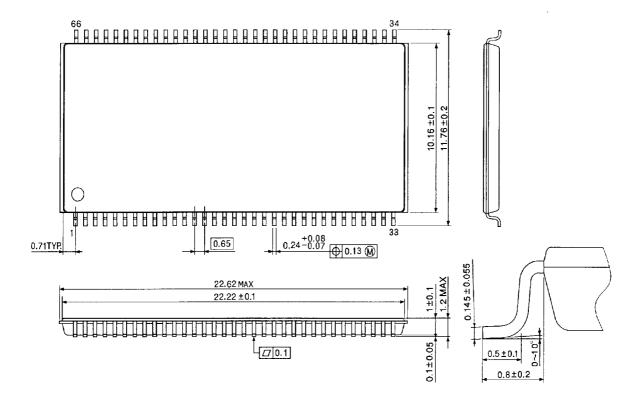
(E-3) Reserved field (A2 to A5, A7 to A14)

These bits are reserved for future operations and must be set to "0" for normal operation.

# **PACKAGE DIMENSIONS**

TSOPII 66-P-400-0.65

Unit: mm



Weight: 0.51 g (typ.)



#### **REVISION HISTORY**

- Rev.1.0 (Feb. 25 '2004)
- Rev1.1 (Aug. 20 '2004)
  - Corrected TYPO (page12~14, 33)
  - Note2 changed as below (page 6)

Before: These parameters depend on the output loading. The specified values are obtained with the

output open.

After: These parameters define the current between  $V_{DD}$  and  $V_{SS}$ .

#### RESTRICTIONS ON PRODUCT USE

030619EBA

- The information contained herein is subject to change without notice.
- The information contained herein is presented only as a guide for the applications of our products. No
  responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which
  may result from its use. No license is granted by implication or otherwise under any patent or patent rights of
  TOSHIBA or others.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- TOSHIBA products should not be embedded to the downstream products which are prohibited to be produced and sold, under any law and regulations.